

Optoelectronic Performance of Vertical Cavity Surface Emitting AlGaAs/GaAs QW Laser in Non-Conventional Orientation

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ABSTRACT

This paper attempts to address a comprehensive in-depth study on the orientation-dependent optoelectronic performance and power-current profile of lattice matched 670nm $\text{Al}_{0.3}\text{Ga}_{0.7}\text{As}/\text{GaAs}$ Single QW Vertical Cavity Surface Emitting Laser (VCSEL) in MATLAB by solving an eight-band $k \cdot p$ Hamiltonian using finite difference method at Γ -point. The analysis is done along conventional (100) as well as non-conventional (110), (111), (113) and (131) crystal orientations. It is seen that there is a substantial correlation of the energy band dispersion profile and peak gain with change of crystal orientation due to change in energy splitting between conduction band to heavy and light hole. Highest optical gain, maximum optical power and minimum threshold current is obtained in (111) crystal orientation. This numerical result demonstrates that (111)-oriented epilayer can be incorporated into the active region of this laser system in order to attain improved performance for ultrahigh speed lightwave communications technology.

General Terms

MATLAB, Energy band dispersion, PI response of QW Laser

Keywords

Crystal Orientation, Surface emitting laser, AlGaAs, Hamiltonian Matrix, Valence Band, Optical Gain

1. INTRODUCTION

Vertical cavity surface emitting lasers (VCSELs) are made by sandwiching light emitting layers between two highly reflective mirrors grown on the principle of distributed Bragg reflectors (DBRs). Narrow beam divergence, low power consumption, high modulation bandwidth, and easy polarization control are major merits of VCSELs over edge emitting lasers [1]. AlGaAs/GaAs VCSEL was first revealed in 1988 and 1990 at Tokyo Institute of Technology [2] and National Taiwan University [3]. This laser system, emitting within 0.63~ 0.9 μm is a prominent candidate in optical pumping sources, DVD players, optical disc readers and laser pointers. Latest research suggests that 670nm laser radiation is a promising modality in endothelial cell (EC) proliferation (key process in tissue repair) and healing of retinal disease which led us to focus on 670 nm AlGaAs surface-emitting laser [4,5].

However, in contrast to edge-emitting lasers, the high reflectance of the output mirror in VCSEL leads to low quantum efficiency and low output power. If the optical gain in the active region is enhanced, the output-mirror reflectance can be reduced with increase in output power [6]. In recent

years, it is unleashed that improved optical gain and threshold current of the lasers can be attained by introducing non-(100)-oriented quantum well (QW) into the active region as the separation between heavy hole (HH) and light hole (LH) is orientation-dependent; so the density of states and speed of carrier transition from valence band (VB) maxima to conduction band (CB) minima at Γ -point. So, crystal orientation is a new way in band structure modifications to optimize QW performance [7].

Modern fabrication techniques such as molecular beam epitaxy (MBE) and metal-organic chemical vapor deposition (MOCVD) permits the growth of crystals in nonconventional orientation. Few results on orientation-dependent growth of InGaAs/InP QW are found in literature [8, 9]. Ohtoshi et al. reported the dependence of optical gain on crystal orientation in InGaAs/InP surface emitting laser [6]. In 2012, M.M. Hasan reported crystallographic orientation-dependent optical properties of GaInSb mid-infrared QW laser on GaSb substrate [10]. To best of our knowledge, the optical emission profile and P-I profile of AlGaAs based VCSEL in non-conventional orientation is still unavailable. Hence, to explore the performance of this laser in arbitrary crystal orientations in details, numerical modeling is necessary.

The purpose of this research is to discuss VCSELs that employ non-(100)-oriented lattice matched quantum wells (QWs) and hence to develop a numerical model to study the energy band structure, emission profile and P-I characteristics as a function of different crystal orientations. Here, we calculate for the first time optoelectronic properties related to arbitrary orientations at Brillouin-zone center to estimate performance of AlGaAs/GaAs QW VCSEL. The present analysis is based on 8*8 $k \cdot p$ Hamiltonian which includes spin-orbit interaction with heavy and light hole. To investigate the optoelectronic properties in non-(100) orientation, spinor rotations are used to modify the wave vectors and Hamiltonian matrix in conventional crystal orientation.

The description of this paper is designed as follows: the theoretical formula to calculate optical properties of the AlGaAs/GaAs QW are mentioned in section 2. Results and discussions on the energy band structure and optical emission spectra are illustrated in section 3. Finally, a summary is depicted in section 4.

2. THEORY

2.1 Laser Structure

AlGaAs/GaAs VCSEL is grown on GaAs substrate. The active region consists of 20nm single $\text{Al}_{0.3}\text{Ga}_{0.7}\text{As}$ layer

sandwiched between 8nm GaAs barrier layer and high band gap $\text{Al}_{0.4}\text{Ga}_{0.6}\text{As}$ is used as cladding layer on top and bottom of QW. Two $\text{Al}_{0.12}\text{Ga}_{0.88}\text{As}/\text{AlAs}$ DBRs of mean reflectivity 99.5% are used as mirrors. In arbitrary crystal orientated laser, the crystal orientation in the active region is (hkl) but all other layers are in (100) crystal orientation. The interface of (100) and (hkl)-oriented layer is joined via wafer bonding technique [11]. Energy Gap E_g of well is noted as [12]:

$$E_g(\text{Al}_x\text{Ga}_{1-x}\text{As}) = E_g(\text{GaAs}) + 1.429*x - 0.14*x^2$$

2.2 k.p Method of Band-Structure Calculation

The electronic energy band profile is solved in the envelope approximation using an eight-band $k\cdot p$ Hamiltonian near Γ -point. The modified Kane 8×8 Hamiltonian matrix can be given by [13]:

$$H_0\psi_h(z) = E\psi_h \quad (1)$$

Strain Hamiltonian is neglected since the QW is lattice matched. The components of Hamiltonian matrix H_0 are:

$$H_0 = \begin{bmatrix} A & 0 & V^* & 0 & \sqrt{3}V & -\sqrt{2}U & -U & \sqrt{2}V^* \\ 0 & A & -\sqrt{2}U & -\sqrt{3}V^* & 0 & -V & \sqrt{2}V & U \\ V & -\sqrt{2}U & -P+Q & -S^* & R & 0 & \frac{\sqrt{3}}{2}S & -\sqrt{2}Q \\ 0 & -\sqrt{3}V & -S & -P-Q & 0 & R & -\sqrt{2}R & \frac{1}{\sqrt{2}}S \\ \sqrt{3}V^* & 0 & R^* & S & -P+Q & S^* & \frac{1}{\sqrt{2}}S^* & \sqrt{2}R^* \\ -\sqrt{2}U & -V^* & 0 & R^* & S & -P+Q & \sqrt{2}Q & \frac{\sqrt{3}}{2}S^* \\ -U & \sqrt{2}V^* & \frac{\sqrt{3}}{2}S^* & -\sqrt{2}R^* & \frac{1}{\sqrt{2}}S & \sqrt{2}Q & -P-\Delta & 0 \\ \sqrt{2}V & U & -\sqrt{2}Q & \frac{1}{\sqrt{2}}S^* & \sqrt{2}R & \frac{\sqrt{3}}{2}S & 0 & -P-\Delta \end{bmatrix} \quad (2)$$

Here, ψ_h is the conduction and valence band wave function component and E is the energy of conduction band and three valence bands.

The matrix elements are:

$$A = E_c - \frac{\hbar^2}{2m_0} (k_x^2 + k_y^2 + k_z^2) \quad (3)$$

$$P = -E_v - \gamma_1 \frac{\hbar^2}{2m_0} (k_x^2 + k_y^2 + k_z^2) \quad (4)$$

$$Q = -\gamma_2 \frac{\hbar^2}{2m_0} (k_x^2 + k_y^2 + k_z^2) \quad (5)$$

$$R = \sqrt{3} \frac{\hbar^2}{2m_0} [\gamma_2 (k_x^2 - k_y^2) - 2i\gamma_3 k_x k_y] \quad (6)$$

$$S = -\sqrt{3}\gamma_3 \frac{\hbar^2}{2m_0} k_z (k_x - ik_y) \quad (7)$$

$$U = \frac{-i}{\sqrt{3}} P_0 k_z \quad (8)$$

$$V = \frac{-i}{\sqrt{6}} P_0 (k_x - ik_y) \quad (9)$$

P_0 is the coupling between the conduction and valence bands, E_c and E_v are the (unstrained) conduction and valence band energies respectively, Δ is the spin orbit splitting and γ_i 's are Luttinger parameters. The energy dispersion profile along (100) orientation is derived as a function of k for the 8-band $k\cdot p$ theory by diagonalizing the Hamiltonian using numerical finite difference scheme.

2.3 Euler's Rotation Scheme

If the active channel is grown on (hkl) crystal orientation, the wave vectors on (100) crystal can be interpreted by the following expression [7]:

$$\begin{pmatrix} k_1 \\ k_2 \\ k_3 \end{pmatrix} = O_R \begin{pmatrix} k_x \\ k_y \\ k_z \end{pmatrix} \quad (10)$$

The expression of the rotation matrix is as follows [16]:

$$O_R = \begin{pmatrix} \cos\theta\cos\phi & -\sin\phi & \sin\theta\cos\phi \\ \cos\theta\sin\phi & \cos\phi & \sin\theta\sin\phi \\ -\sin\theta & 0 & \cos\theta \end{pmatrix}$$

Where, $\theta = \tan^{-1} \frac{\sqrt{h^2+k^2}}{l}$ and $\phi = \tan^{-1} \frac{k}{h}$

Applying the wave vector in the (100) crystal orientation, the Hamiltonian matrix for (100) crystal orientation can be calculated according to eq. 2. Then the Hamiltonian matrix in (hkl) orientation can be counted by the simple equation:

$$H^{hkl} = U H^{(100)} U^* \quad (11)$$

Where, $U = R(\theta)R(\phi)$

In this formulae, $R(\theta)$ and $R(\phi)$ are denoted as rotations which transform the (100) orientated valence band Hamiltonian to arbitrary crystal orientated Hamiltonian matrix. The argument of $R(\theta)$ and $R(\phi)$ can be defined by:

$$R(\theta) = \begin{pmatrix} \alpha^2 & -\sqrt{3}\alpha^2\xi & \sqrt{3}\alpha\xi^2 & \xi^3 \\ \sqrt{3}\alpha^2\xi & \alpha^3 - 2\alpha\xi^2 & -2\alpha^2\xi + \xi^3 & \sqrt{3}\alpha\xi^2 \\ \sqrt{3}\alpha\xi^2 & 2\alpha^2\xi - \xi^3 & \alpha^3 - 2\alpha^2\xi & -\sqrt{3}\alpha^2\xi \\ \xi^3 & \sqrt{3}\alpha\xi^2 & \sqrt{3}\alpha^2\xi & \alpha^3 \end{pmatrix} \quad (12)$$

$$R(\phi) = \begin{pmatrix} e^{i(\frac{3}{2})\phi} & 0 & 0 & 0 \\ 0 & e^{i(\frac{1}{2})\phi} & 0 & 0 \\ 0 & 0 & e^{-i(\frac{1}{2})\phi} & 0 \\ 0 & 0 & 0 & e^{-i(\frac{3}{2})\phi} \end{pmatrix} \quad (13)$$

Here, $\alpha = \cos(\frac{\theta}{2})$ and $\xi = -\sin(\frac{\theta}{2})$

These rotations of the Euler angles θ and ϕ transform the basis states from (x,y,z) coordinates to (x',y',z') coordinates as shown in Fig. 1.

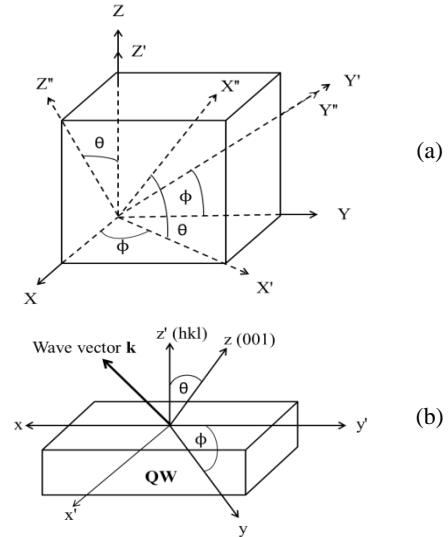


FIG. 1: (a) Spinor Rotation Schematics (b) Configuration of coordinate systems in VCSELs with (hkl)-oriented QWs

2.4 Optical Gain and Momentum Matrix

The optical gain as a function of energy for quantum well structure can be approximated by [10]:

$$g(E) = \frac{2q^2\hbar}{n\epsilon_0 c m_0^2 L E} \times \sum_{n,m} \int_0^\infty \frac{\frac{k_t M_{nm}(k_t)\Gamma}{2\pi}}{(E_{cn}(k_t) - E_{kpm}(k_t) - E)^2 + (\Gamma/2\pi)^2} (f_c^n - f_v^m) dk_t \quad (14)$$

Here, q is denoted as free electron charge, \hbar is the reduced Planck constant, n is the index of refraction, ϵ_0 is the free space dielectric constant, c is the speed of light, E is the photon energy, E_{cn} is the conduction band energy, E_{kpm} is the m^{th} valence sub-bands, and M_{nm} is the momentum matrix element in strained quantum well architecture. $\Gamma = \hbar/\tau$ where, τ is the photon relaxation time. f_c and f_v are the Fermi levels of conduction and valence bands.

In a QW structure, the optical momentum matrix element will depend mainly on the transverse electric (TE) polarization of the optical electromagnetic field. The momentum matrix element for TE polarization can be written as [14]:

$$M_{nm}(k_t)[TE] = g^{(1)}(e^{i(\frac{\Delta_2}{\hbar})\phi})^* \cos\theta \left(\frac{m_0 P_2}{\hbar}\right) + g^{(2)}(e^{i(\frac{\Delta_1}{\hbar})\phi}) \cos\theta \left(\frac{m_0 P_2}{\hbar}\right) - g^{(3)}(e^{i(\frac{\Delta_1}{\hbar})\phi})^* \cos\theta \left(\frac{m_0 P_1}{\hbar}\right) \quad (15)$$

$$P_1^2 = \frac{\hbar^2}{2m_0} \left(\frac{m_0}{m_e^*} - 1\right) \frac{(E_g + \Delta_1 + \Delta_2)(E_g + 2\Delta_2^2)}{E_g + 2\Delta_2}$$

$$P_2^2 = \frac{\hbar^2}{2m_0} \left(\frac{m_0}{m_e^*} - 1\right) \frac{E_g[(E_g + \Delta_1 + \Delta_2)(E_g + 2\Delta_2^2)]}{(E_g + \Delta_1 + \Delta_2)(E_g + 2\Delta_2) - \Delta_1^2}$$

Here, Δ_1 , Δ_2 = Energy splitting between conduction band to light hole and spin orbit split-off hole

2.5 P-I Response

Two-level rate equations that account for carriers in the active and SCH (Separate Confinement Heterostructure /barrier) layers is converted into equivalent circuit via PSPICE to find output power P vs. current I response in different crystal orientation [15,16]. The model equations found in [15], are

$$\frac{dN_b}{dt} = \frac{\eta_i I}{qV_{barr}} - R_b(N_b) - \frac{N_b}{\tau_{capt}} + \frac{N_w V_{act} N}{V_{barr} \tau_{em}} \quad (16)$$

$$\frac{dN}{dt} = \frac{V_{barr} N_b}{N_w V_{act} \tau_{capt}} - \frac{N}{\tau_{em}} - R_w(N) - \Gamma_c v_{gr} \frac{\alpha(N)}{\phi(S)} S \quad (17)$$

$$\frac{dS}{dt} = -\frac{S}{\tau_p} + N_w R_{w\beta}(N) + N_w \Gamma_c v_{gr} \frac{\alpha(N)}{\phi(S)} S \quad (18)$$

$$\frac{S}{P_f} = \frac{\lambda \tau_p}{\eta_c V_{act} \hbar c} = \vartheta \quad (19)$$

$$\alpha(N) = G_0 \ln \left(\frac{R_w(N)}{R_w(N_0)}\right)$$

$$\text{Gain Saturation } \phi(S) = \frac{1}{1 + \varepsilon \Gamma_c S}$$

$$R_{W,b} = A_{W,b} N_{W,b} + B_{W,b} N_{W,b}^2 + C_{W,b} N_{W,b}^3$$

Here, Eq. (16) is the rate equation for carrier density N_b in the SCH layer and relates its rate of change to the injection current I, the SCH recombination rate, and the carrier exchange between the SCH layers and QW's, namely the rate of carrier capture and emission by the QW's. Eq. (17) accounts for the carrier exchange between the SCH layers and QW's with capture rate of carriers from the SCH layer and carrier emission from the QW's. Eq. (18) and (19) are for photon density and power. A, B and C are trap aided, radiative and Auger recombination coefficients for well and barrier.

$$\text{Photon lifetime is calculated: } \tau_p^{-1} = v_{gr} \left[\alpha_i + \frac{\ln\left(\frac{1}{L_c}\right)}{L_c}\right]$$

Here, α_i = internal cavity loss, R_m = mean reflectivity and L_c = cavity length

Output power coupling coefficient is determined using:

$$\eta_c = 0.5 \ln\left(\frac{1}{R_m}\right) / \left[\alpha_i L_c + \ln\left(\frac{1}{R_m}\right)\right]$$

Relevant material parameters like lattice constant, deformation potential etc. are taken from [17]. Parameters for evaluating output optical power profile are shown in Table 1.

3. RESULTS AND DISCUSSION

Following the k.p method formula given in Section 2.2, the optical properties of lattice matched 20 nm ZB GaAs/Al_{0.3}Ga_{0.7}As QW VCSEL structure at the Γ -point have been studied. The simulation is carried out in MATLAB environment at room temperature. The valence band dispersion curves obtained in (100), (110), (111), (113) and (131) crystal orientations for the first Brillouin zone have been shown in Fig. 2 (a)-(e). To compare the orientation dependent energies, the figures are plotted as a function of wave vector in the same scale. It has been observed, for

values of $k \neq 0$ (wave vector in the plain direction), the increasing conduction and spin-orbit split off band coupling offer strong anisotropy of the topmost valence band structure at (110) and (113) orientation.

Table 1. Parameters for Output Power Profile

Name	Symbol (unit)	Value
Current-injection efficiency	η_i	0.86
Ambipolar Diffusivity	D_a (cm ² s ⁻¹)	4.4
Volume of one QW	V_{act} (m ³)	5*10 ⁻¹⁸
Optical confinement factor	Γ_c	0.022
Output power coupling coefficient	η_c	0.522
QW trap-aided recombination coefficient	A_w (s ⁻¹)	1.3*10 ⁸
QW radiative recombination coefficient	B_w (cm ³ s ⁻¹)	1.4*10 ⁻¹⁰
QW Auger recombination coefficient	C_w (cm ⁻⁶ s ⁻¹)	1.3*10 ⁻²⁹
SCH trap-aided recombination coefficient	A_b (s ⁻¹)	5*10 ⁸
SCH radiative recombination coefficient	B_b (cm ³ s ⁻¹)	3.6*10 ⁻¹¹
SCH Auger recombination coefficient	C_b (cm ⁻⁶ s ⁻¹)	8*10 ⁻³⁰
Phenomenological gain-saturation term	ε	4*10 ⁻¹⁷
Radiative recombination coupling	β_B	1*10 ⁻⁴
Volume of SCH	V_{barr} (m ³)	2.1*10 ⁻¹⁶
QW capture lifetime	τ_{capt} (ps)	0.97
QW emission lifetime	τ_{em} (ps)	10
Internal loss of the cavity	α_i (cm ⁻¹)	20
Mean mirror reflectivity	R_m	0.99
Cavity length	L_c (μ m)	100

Light emission occurs from lasers due to the allowed transition from conduction band (C) to HH. Other transitions such as intra-subbands transitions are prohibited because it decreases the gain of the laser. Among the intra-subbands, transition probability is highest between HH and LH, which is minimized when the energy separation between them is higher. For (111) orientation, larger energy spacing between HH and LH has been observed which changes the topmost curvature of valence sub-bands and results in the variation of electron and hole mass m^* . In order to explain the wavelength dependence of emission profile, the energy separation between the C-HH and HH-LH bands is estimated from the energy band dispersion profiles and shown in Table 2. It is found that the energy separation between conduction band minima and valence band maxima changes with crystal plane orientations. It can be noted from this table that the intraband mixing effect is minimum for this laser along (111) orientation. The orientation dependent peak gain can be revealed by the momentum matrix elements that depend on the overlapping wave functions of electrons and holes. It is observed from fig. 3 that transition probability is maximum in (111) orientation and least in (110) and (100) orientations. The lowest band gap and minimum intraband interaction is responsible for the improved result along (111). Here we have calculated the optical gain spectra in different crystal orientations using Eq. (14) and shown in Fig. 4. Here highest gain of 4250 cm⁻¹ is observed in (111) crystal orientation and lowest gain of 2940 cm⁻¹ is in (100) orientation. Highest gain in (111) crystal orientation is obtained due to the small band

mixing effect and greater transition probability. For this similar issue, minimum gain is observed in (100) crystal orientation. The peak emission wavelength is found to be shifted from 670 to 695 nm.

The crystal orientation-dependent differential gain is calculated and shown in fig.5. Maximum differential gain is obtained along (111) crystal orientation when the injection carrier density is $3.6 \times 10^{16} \text{ cm}^{-3}$. Peak values of gain profile from fig. 4 and injection carrier density from fig. 5 are used in PSPICE equivalent circuit to find P-I response.

Optical power-injection current characteristics determined for GaAs/ $\text{Al}_{0.3}\text{Ga}_{0.7}\text{As}$ QW laser in different crystal orientations are shown in fig. 6. It is found that the maximum optical power of 4.35mW and minimum threshold current of 4.96mA are obtained in (111) orientated VCSEL structure. On the other hand, the maximum threshold current is evaluated to be 7.6 mA in (100) crystal orientation.

So, it is quite visible from the above discussion that (111)-oriented vertical cavity surface emitting AlGaAs/GaAs Laser system leads to have improved performance than (100)-oriented structure.

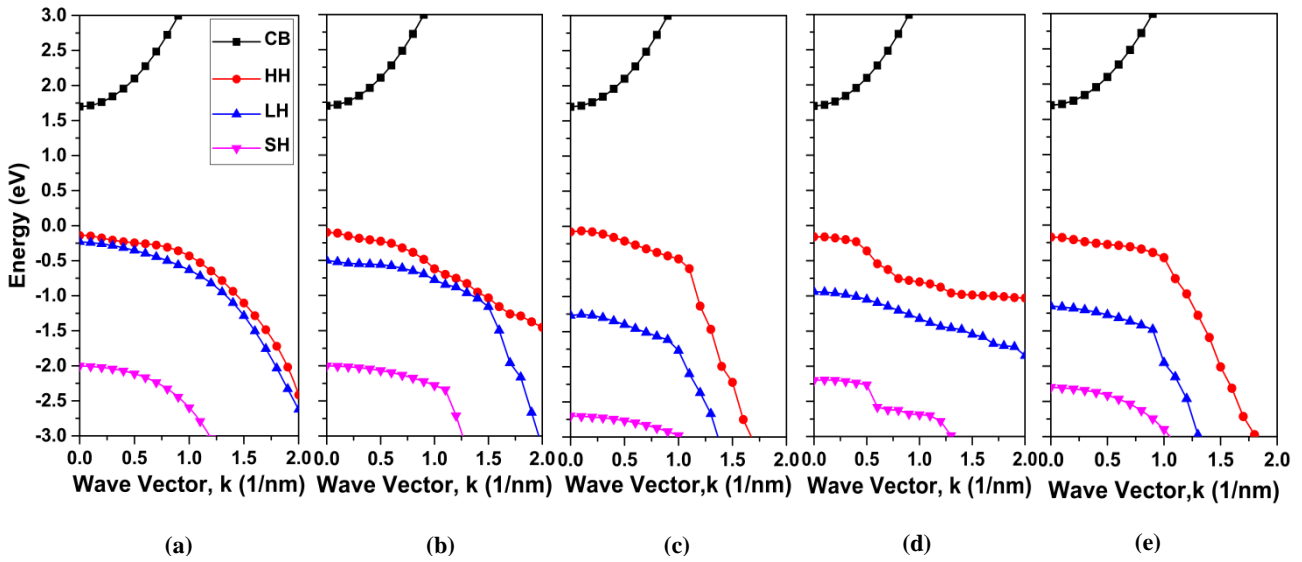


Fig 2: Energy band dispersion profile of (a) (100) (b) (110) (c) (111) (d) (113) and (e) (131)-oriented AlGaAs/GaAs VCSE Laser [CB=conduction band, HH=Heavy Hole, LH=light hole, SH= spin-orbit split-off hole]

Table 2: Orientation-Dependent Energy Separation

Crystal orientation	Angle w.r.t z-axis	C-HH(eV)	HH-LH(eV)
(100)	0°	1.84	0.09
(110)	90°	1.80	0.4
(111)	54.7°	1.78	1.19
(113)	25.2°	1.86	0.78
(131)	72.5°	1.87	0.98

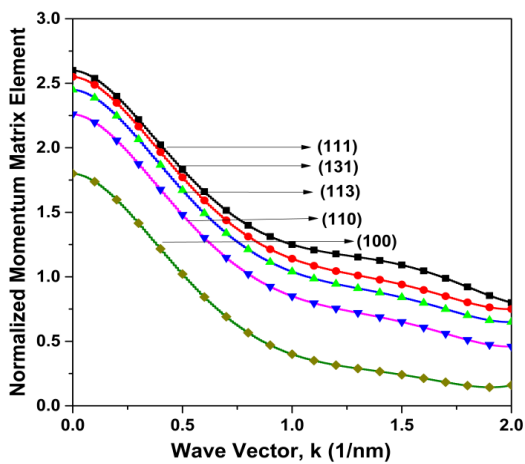


Fig 3: Crystal orientation-dependent normalized momentum matrix element squared for C-HH transition

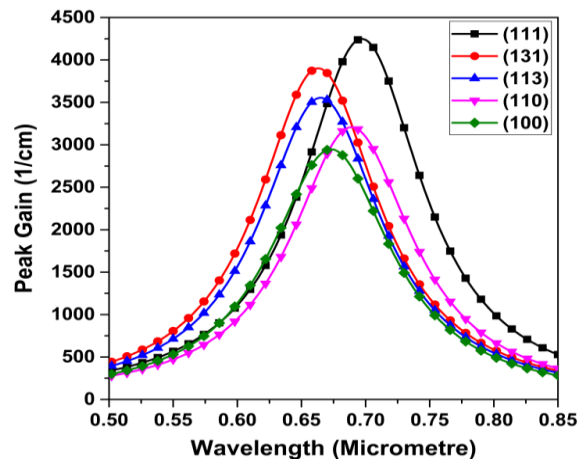


Fig 4: Crystal orientation-dependent Optical Emission Profile

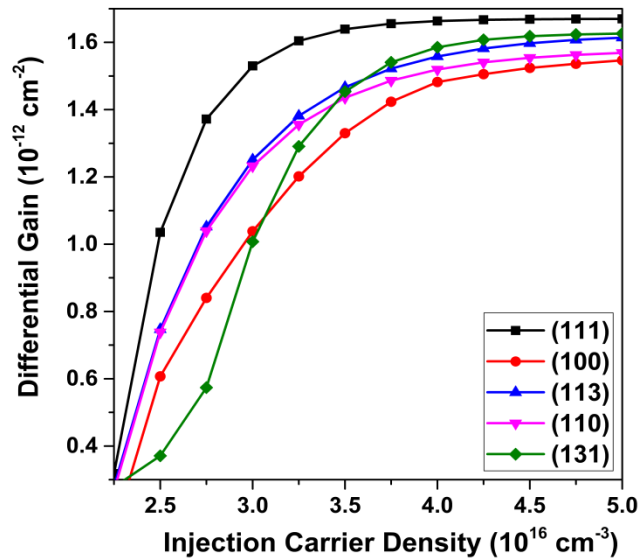


Fig 5: Differential gain in Different Orientation

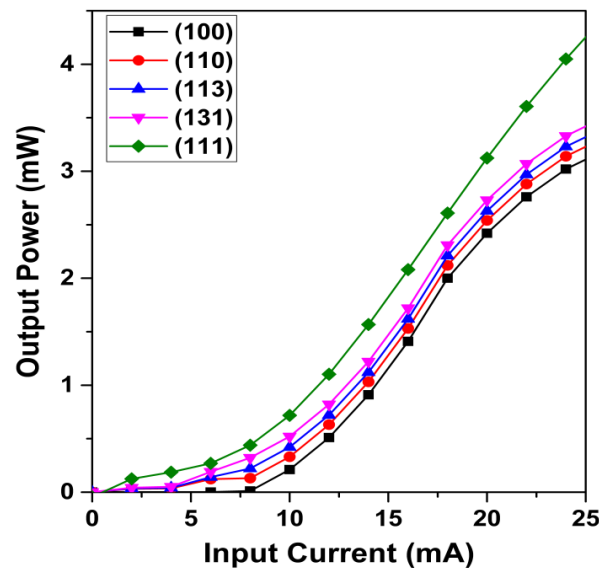


Fig 6: Orientation-dependent Output Power Characteristics

4. CONCLUSION

AlGaAs laser emitting around 670 nm is analysed in (100) as well as non-conventional crystal orientation in MATLAB and PSPICE environment using 8-band k.p matrix and subsequent tensor rotation formula. It's seen that crystal orientation alters energy gap between conduction and valence sub-bands. Highest momentum of carrier transition between conduction and heavy hole band and peak gain is obtained in (111) crystal orientation (an angle of 54.7° w.r.t (100) plane) because of highest energy separation between valence subbands in this orientation. It is also seen that peak emission wavelength of the proposed laser shows adjustable characteristics and it varies from 670 to 695 nm for changing crystal orientation from (131) to (111). Alongside with this, from the inspection of output optical power and threshold current, it can be said that (111)-oriented structure gives the best performance. As modern era's lightwave communication technology is now tending towards over 40 gbit/s class architecture, (111)-

oriented AlGaAs vertical cavity surface emitting laser system is a prospective candidate for ultra-high speed ICs.

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